

**Notice of References Cited**

Application/Control No.

09/864,107

Applicant(s)/Patent Under

examination

VAN LIERE, FILIPS

Examiner

Jin-Cheng Wang

Art Unit

2672

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,740,267 ✓	04-1998	Echerer et al.	382/132
	B	US-5,454,371 ✓	10-1995	Fenster et al.	600/443
	C	US-6,083,162	07-2000	Vining, David J.	600/407
	D	US-6,424,996	07-2002	Killcommons et al.	709/206
	E	US-5,898,797	04-1999	Weiss et al.	382/199
	F	US-6,115,481	09-2000	Wiens, Daniel W.	382/113
	G	US-5,832,422	11-1998	Wiedenhoefer, Curt	702/154
	H	US-6,346,940	02-2002	Fukunaga, Tomohisa	345/427
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.